

Notice of References Cited	Application/Control No. 10/774,142		Applicant(s)/Patent Under Reexamination YOSHIDA ET AL.	
	Examiner CHAN S. PARK		Art Unit 2625	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,151,464	11-2000	Nakamura et al.	399/79
*	B	US-2002/0048042	04-2002	Iwase et al.	358/1.15
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	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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